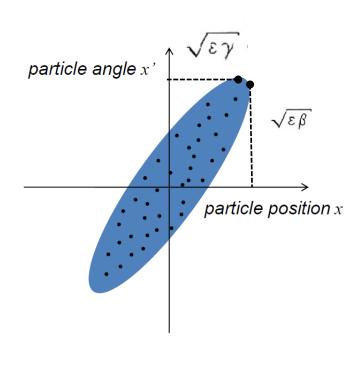
# PHY542. Emittance Measurements using solenoid scan

D. Kayran, M. Fedurin Apr 10, 2023

PHY 542 Fundamentals of Accelerator Physics and Technology with Simulations and Measurements Lab

# Emittance, what is it ?



 $\epsilon$  = Area in x, x' plane occupied by beam particles divided by  $\pi$ 

Beam ellipse and its orientation is described by 4 parameters

 $\varepsilon = \gamma x^2 + 2 \alpha x x' + \beta x'^2$ 

 $\sqrt{\beta\varepsilon}$  Is the beam half width Is the beam half divergence

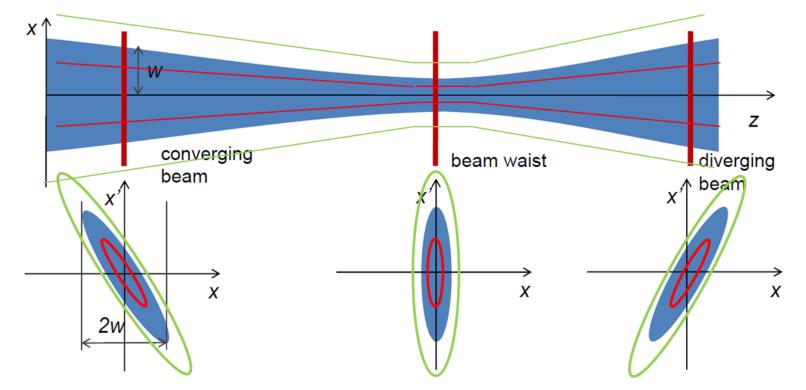
 $\sqrt{\gamma \varepsilon}$  Describes how strong x and x' are correlated

α <0 beam diverging</li>
a>0 beam converging
a=0 beam size is maximum or
minimum(waist)

The three orientation parameters are connected by the relation

$$\gamma = \frac{1 + \alpha^2}{\beta}$$

### Beam envelope along a beamline.



Along a beamline the orientation and aspect ratio of the beam ellipse in x, x' changes, but area (emittance) remains constant.

Alike initial beam distributions have similar phase space dynamics

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Beam width along Z is described
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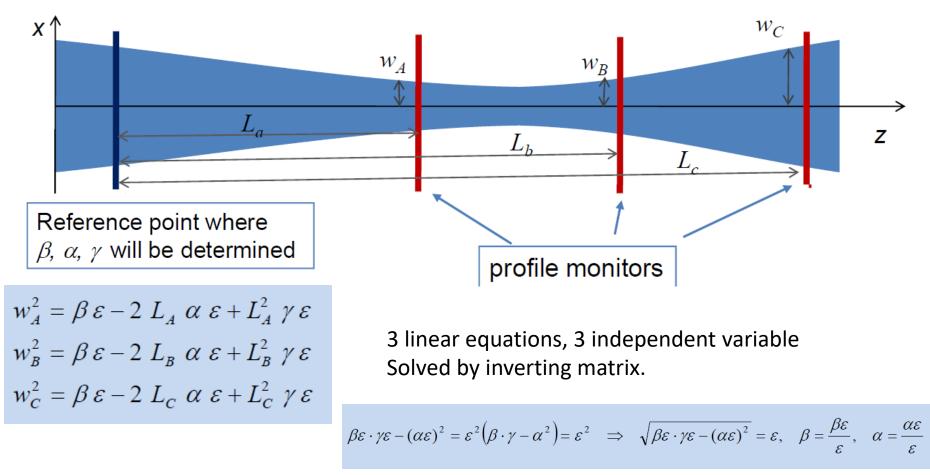
$$w(z) = \sqrt{\beta(z)\,\varepsilon}$$

 $\beta(z)$  describes the beam line,  $\epsilon$  – describes beam quality

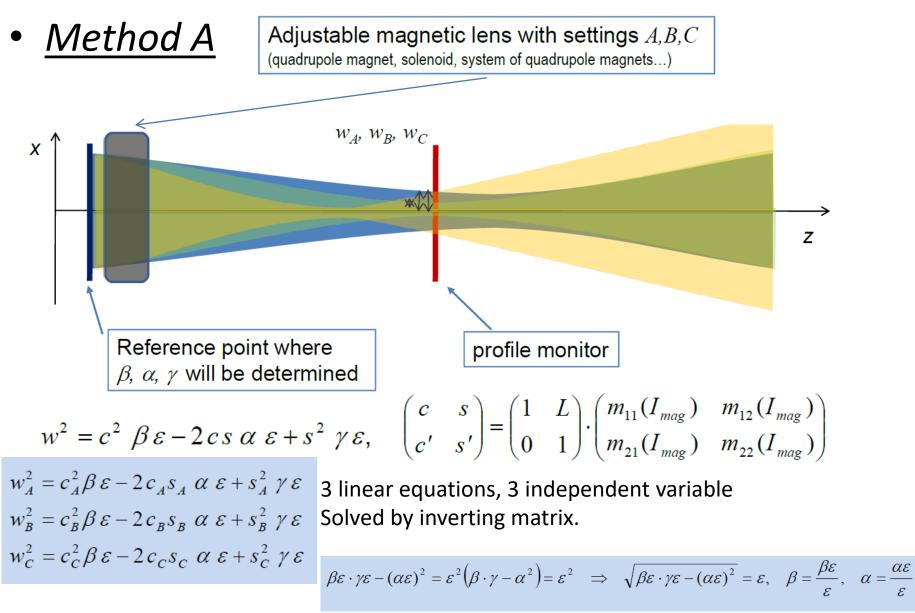
# Emittance measurement in transfer line or linac

Twiss parameters  $\alpha$ ,  $\beta$ ,  $\gamma$  are a priori not known, they have to be determined together with emittance  $\varepsilon$ 

Method A



### Emittancemeasurement in transfer line or linac, (count.)



# Summary beam profile technics

- To determine ε, β, α at a reference point in a beamline one needs at least 3 w measurements with different transfer matrices between the reference point and the w measurements location.
- Different transfer matrices can be achieved with different profile monitor locations, different focusing magnet settings or combinations of both.
- Once  $\beta$ ,  $\alpha$  at one reference point is determined the values of  $\beta$ ,  $\alpha$  at every point in the beamline can be calculated.

Measurements for more different matrix helps to reconstruct emittance better

# Emittance reconstruction from beam profiles measurements in the drift space

If space charge effects are neglectable then rms beam radius  $x_{rms}^2(s)$  in drift space is parabola

- 1. Collect data from several BPMs at different location s
- 2. Fit parabola

$$x_{rms}^2(s) = as^2 + bs + c$$

3. If A,B,C defines in the follow form:

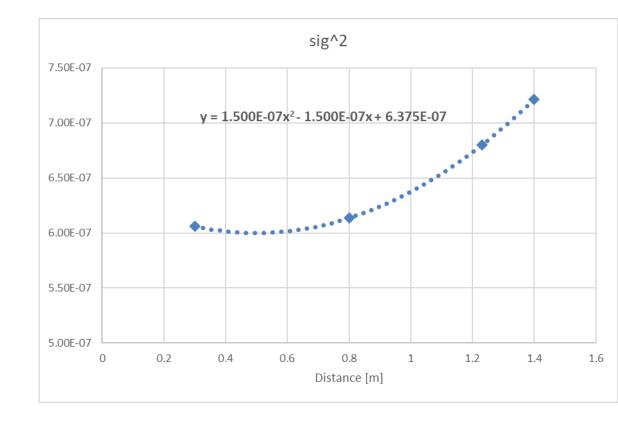
$$x_{rms}^2(s) = \varepsilon\beta(s) = As^2 - 2ABs + (C + AB^2)$$

4. then emittance can be calculated :

$$\varepsilon = \sqrt{AC}$$

5. Please note that value of B gives the location of the beam envelope waist

### Example of 4BPMS data analysis



S	sig	sig^2		
0.3	0.0007785	0.00000606		
0.8	0.0007833	6.135E-07		
1.23	0.0008246	6.79935E-07		
1.4	0.0008494	7.215E-07		

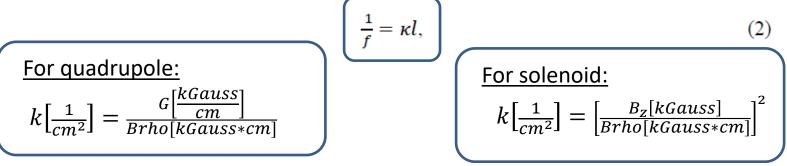
	a b		c A		B C		emit
x	1.50E-07	-1.50E-07	6.38E-07	1.500E-07	5.000E-01	6.000E-07	3E-07

# Quadrupole or solenoid scan

The quadrupole scan technique is a standard technique used in accelerator facilities to measure the transverse emittance. It is based on the fact that the squared rms beam radius  $(x_{rms}^2)$  is proportional to the quadrupole "strength" or inverse focal-length f squared, so

$$x_{rms}^2 = \langle x^2 \rangle = A\left(\frac{1}{f^2}\right) - 2AB\left(\frac{1}{f}\right) + (C + AB^2) \tag{1}$$

where A, B, C are constants and f is the focal length defined as



here  $\kappa$  is the magnet focusing strength in units of 1 over length squared and l is the effective length of the magnet.

The emittance can be estimated according to

$$\varepsilon = \frac{\sqrt{AC}}{d^2} \tag{3}$$

where d is the distance from the magnet you scan to the point you calculate the beam rms radius.

# Example of Quadrupole scan data analysis from

#### previous year

I, A	sx, pix	sy, pix	sx, m	sy, m	p <i>,</i> 1/m	sx^2	sy^2
5.5	45	12	0.000639	0.0001788	0.644596	4.08321E-07	3.2E-08
6	38	11	0.0005396	0.0001639	0.703195	2.91168E-07	2.69E-08
6.5	29	10	0.0004118	0.000149	0.761795	1.69579E-07	2.22E-08
7	22	9.3	0.0003124	0.0001386	0.820395	9.75938E-08	1.92E-08
7.5	15.7	8.8	0.0002229	0.0001311	0.878994	4.97022E-08	1.72E-08
8	10	7.7	0.000142	0.0001147	0.937594	2.0164E-08	1.32E-08
8.5	20.5	6.7	0.0002911	9.983E-05	0.996193	8.47392E-08	9.97E-09
9	32	5.8	0.0004544	8.642E-05	1.054 0.00	00005	

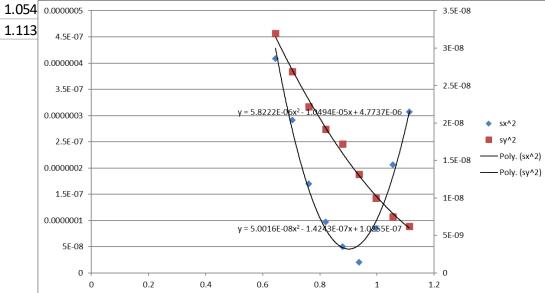
7.897E-05

0.0005538

5.3

9.5

39



	а	b	С	Α	В	С	е	en
У	5.002E-08	-1.424E-07	1.026E-06	5.002E-08	1.424E+00	9.241E-07	9.216E-09	1.039E-06
х	5.822E-06	-1.049E-05	4.774E-06	5.822E-06	9.012E-01	4.507E-08	2.196E-08	2.475E-06